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## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of Applicants:

Date: December 6, 2002

B. S. Beaman et al.

Group Art Unit: 3729

Serial No.: 09/972,622

Examiner: T. V. Nguyen

Filed: October 9, 2001

Docket No.: YO995-023US4

For: HIGH DENSITY INTEGRAL TEST PROBE AND FABRICATION METHOD

Assistant Commissioner for Patents  
Washington, D. C. 20231

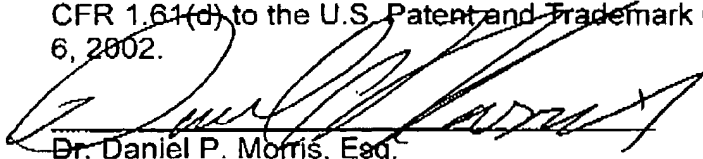
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GROUP 3700

I hereby certify that this paper (1 page) is being facsimile transmitted under Rule 37 CFR 1.61(d) to the U.S. Patent and Trademark Office to (703) 872-9302 on December 6, 2002.

  
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Reg. No. 32,053

**RESPONSE TO RESTRICTION REQUIREMENT**  
**DATED SEPTEMBER 25, 2002**

## Remarks

Applicants elect, without traverse, Group I (claims 1-15).

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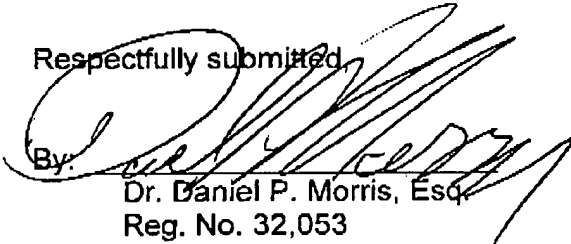
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